



**AO4474**

**N-Channel Enhancement Mode Field Effect Transistor**



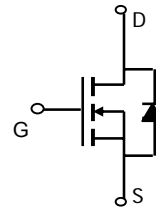
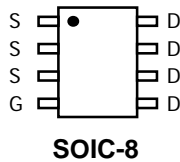
**General Description**

The AO4474/L uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge. This device is suitable for use as a high side switch in SMPS and general purpose applications.  
*AO4474 and AO4474L are electrically identical.*  
 -RoHS Compliant  
 -AO4474L is Halogen Free

**Features**

$V_{DS} (V) = 30V$   
 $I_D = 13.4A \quad (V_{GS} = 10V)$   
 $R_{DS(ON)} < 11.5m\Omega \quad (V_{GS} = 10V)$   
 $R_{DS(ON)} < 13.5m\Omega \quad (V_{GS} = 4.5V)$

**UIS Tested**  
**Rg,Ciss,Coss,Crss Tested**



**Absolute Maximum Ratings  $T_A=25^\circ C$  unless otherwise noted**

| Parameter   | Symbol         | Maximum          | Units      |
|---|----------------|------------------|------------|
| Drain-Source Voltage                              | $V_{DS}$       | 30               | V          |
| Gate-Source Voltage                               | $V_{GS}$       | $\pm 12$         | V          |
| Continuous Drain Current <sup>A, F</sup>          | $I_{DSM}$      | $T_A=25^\circ C$ | 13.4       |
|   |                | $T_A=70^\circ C$ | 10.7       |
| Pulsed Drain Current <sup>B</sup>                 | $I_{DM}$       | 60               | A          |
| Power Dissipation                                 | $P_D$          | $T_A=25^\circ C$ | 3.7        |
|   |                | $T_A=70^\circ C$ | 2.4        |
| Avalanche Current <sup>B, G</sup>                 | $I_{AR}$       | 42               | A          |
| Repetitive avalanche energy 0.1mH <sup>B, G</sup> | $E_{AR}$       | 88               | mJ         |
| Junction and Storage Temperature Range            | $T_J, T_{STG}$ | -55 to 150       | $^\circ C$ |

**Thermal Characteristics**

| Parameter                                | Symbol          | Typ          | Max | Units        |
|--|-----------------|--------------|-----|--------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | $t \leq 10s$ | 28  | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup> |                 | Steady-State | 57  | $^\circ C/W$ |
| Maximum Junction-to-Lead <sup>C</sup>    | $R_{\theta JL}$ | 16           | 23  | $^\circ C/W$ |

Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions   | Min | Typ         | Max        | Units            |
|-----------------------------|---------------------------------------|--|-----|-------------|------------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |             |            |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}$ , $V_{GS}=0\text{V}$  | 30  |             |            | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=30\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                 |     |             | 1<br>5     | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 12\text{V}$                                       |     |             | 0.1        | $\mu\text{A}$    |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$   | 1   | 1.55        | 2.5        | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=10\text{V}$ , $V_{DS}=5\text{V}$   | 60  |             |            | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=13.4\text{A}$<br>$T_J=125^\circ\text{C}$                |     | 9.5<br>16.2 | 11.5<br>18 | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}$ , $I_D=10\text{A}$  |     | 11          | 13.5       | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=13.4\text{A}$  |     | 40          |            | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$   |     | 0.74        | 1.0        | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |  |     |             | 5          | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |             |            |                  |
| $C_{iss}$                   | Input Capacitance                     |  |     | 1210        | 1452       | pF               |
| $C_{oss}$                   | Output Capacitance                    | $V_{GS}=0\text{V}$ , $V_{DS}=15\text{V}$ , $f=1\text{MHz}$                         |     | 330         | 396        | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |  |     | 85          | 119        | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                          | 0.8 | 1.2         | 1.6        | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |             |            |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     |  |     | 22          | 28         | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $I_D=13.4\text{A}$                     |     | 10          | 13         | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |  |     | 3.7         |            | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |  |     | 2.7         |            | nC               |
| $t_{D(on)}$                 | Turn-On Delay Time                    |  |     | 10          |            | ns               |
| $t_r$                       | Turn-On Rise Time                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $R_L=1.1\Omega$ ,<br>$R_{GEN}=3\Omega$ |     | 6.3         |            | ns               |
| $t_{D(off)}$                | Turn-Off Delay Time                   |  |     | 21          |            | ns               |
| $t_f$                       | Turn-Off Fall Time                    |  |     | 2.8         |            | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=13.4\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                               |     | 36          | 45         | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=13.4\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                               |     | 47          |            | nC               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=13.4\text{A}$ , $dI/dt=500\text{A}/\mu\text{s}$                               |     | 20          | 27         | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=13.4\text{A}$ , $dI/dt=500\text{A}/\mu\text{s}$                               |     | 55          |            | nC               |

A: The value of  $R_{\theta JA}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C: The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

F: The current rating is based on the  $t \leq 10\text{s}$  junction to ambient thermal resistance rating.

G:  $L=100\mu\text{H}$ ,  $V_{DD}=0\text{V}$ ,  $R_G=0\Omega$ , rated  $V_{DS}=30\text{V}$  and  $V_{GS}=10\text{V}$

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

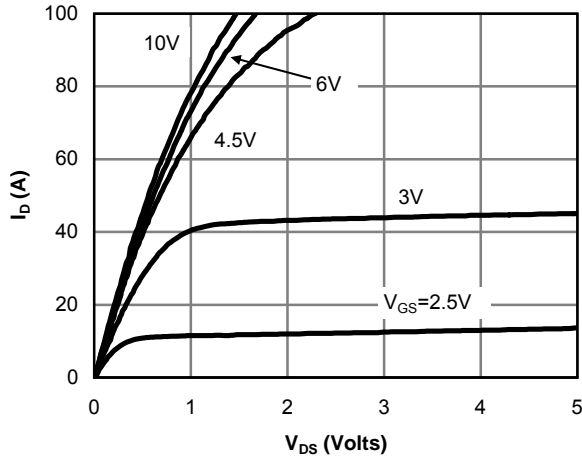


Fig 1: On-Region Characteristics

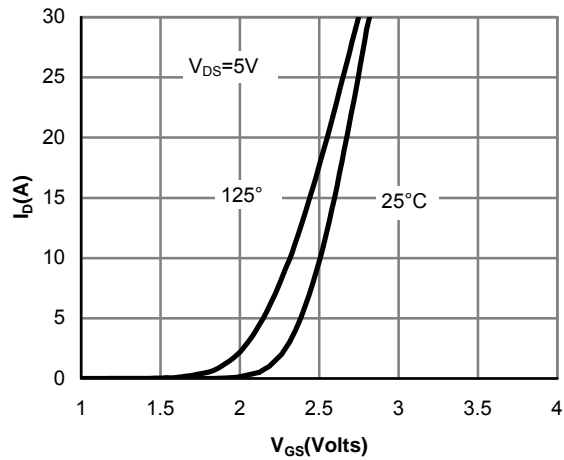


Figure 2: Transfer Characteristics

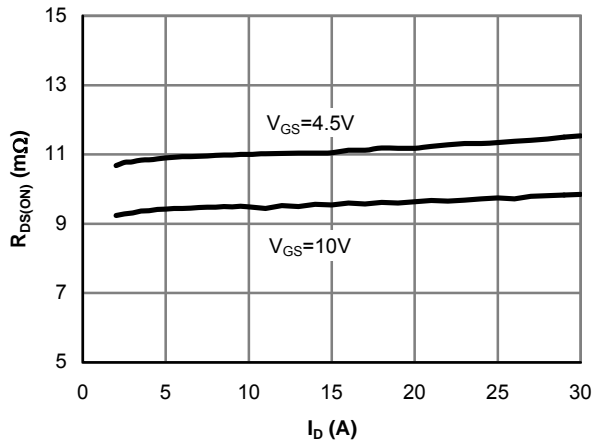


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

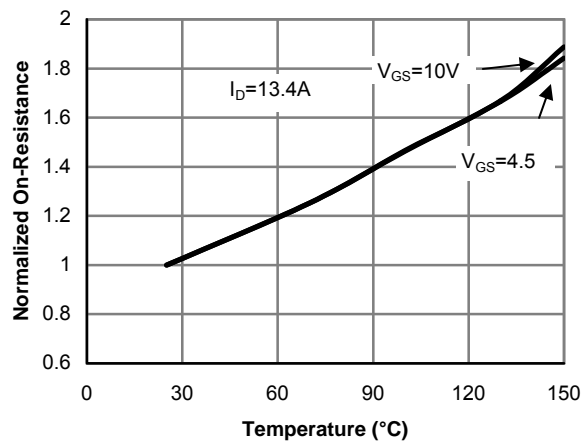


Figure 4: On-Resistance vs. Junction Temperature

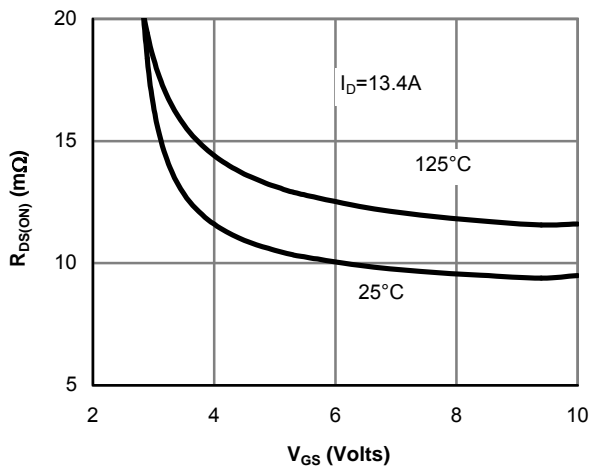


Figure 5: On-Resistance vs. Gate-Source Voltage

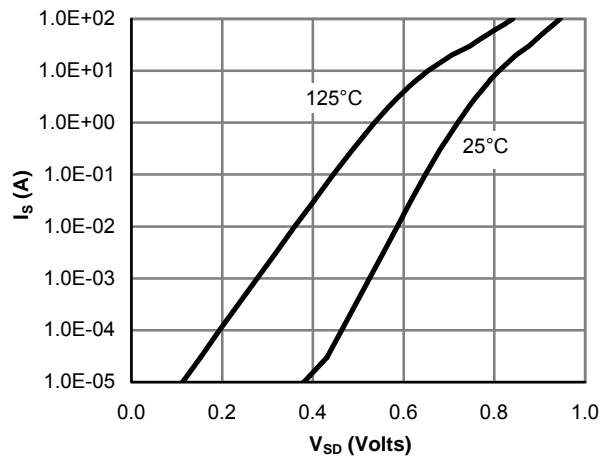


Figure 6: Body-Diode Characteristics

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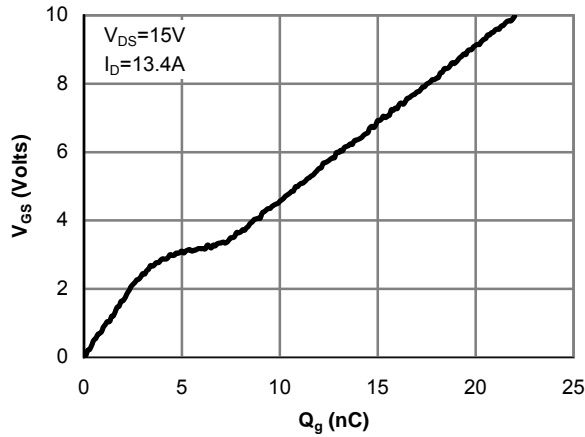


Figure 7: Gate-Charge Characteristics

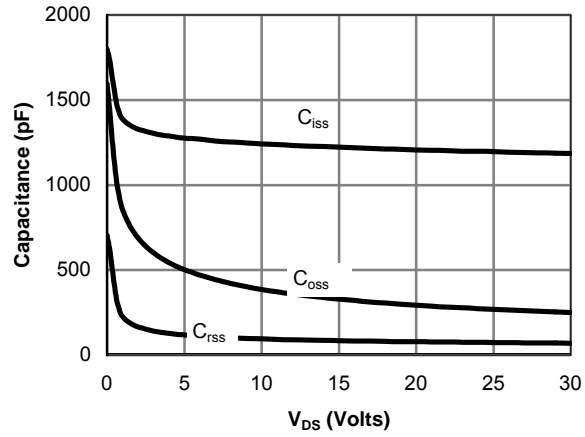


Figure 8: Capacitance Characteristics

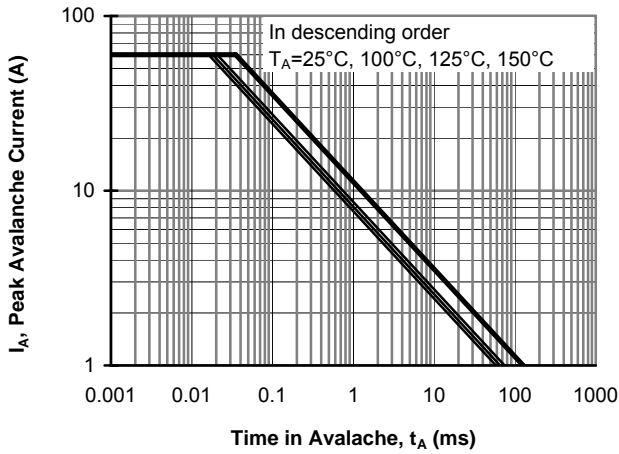


Figure 9: Single Pulse Avalanche Capability

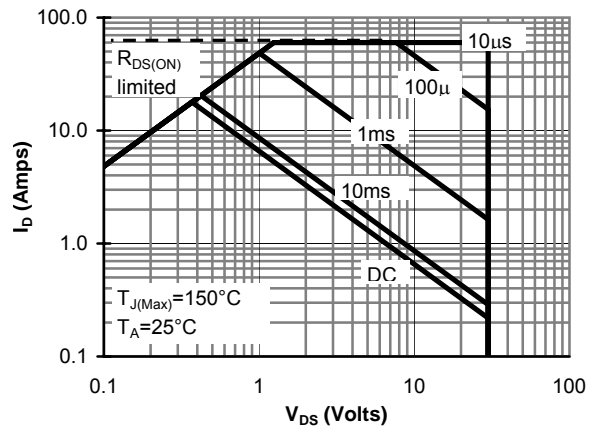


Figure 10: Maximum Forward Biased Safe Operating Area (Note F)

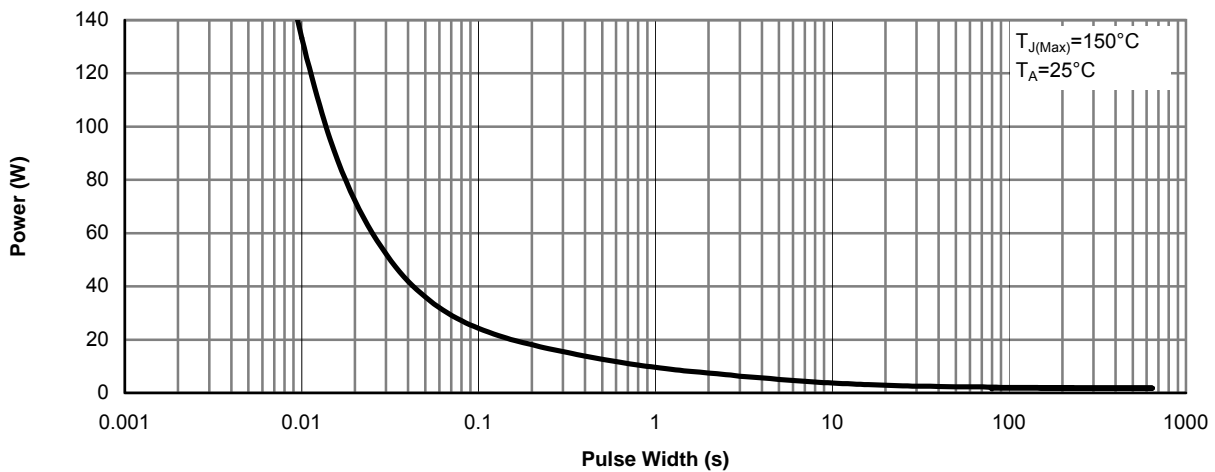


Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note G)

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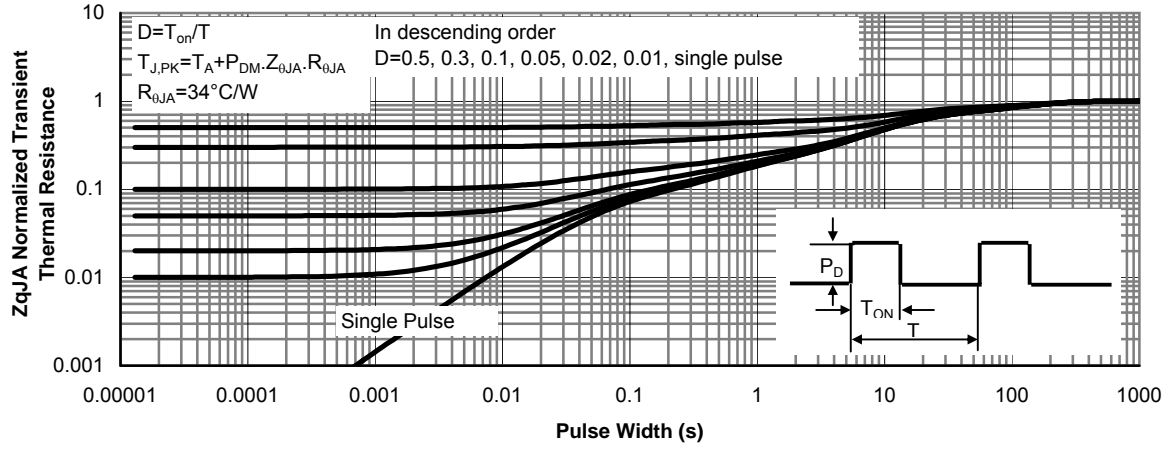


Figure 12: Normalized Maximum Transient Thermal Impedance (Note G)